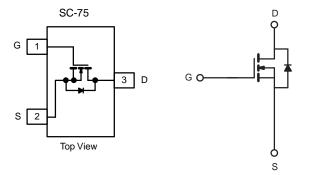


# FDY302NZ-NL-VB Datasheet

N-Channel 20 V (D-S) MOSFET

| PRODUCT SUMMARY     |                                  |                                 |                       |  |  |  |
|---------------------|----------------------------------|---------------------------------|-----------------------|--|--|--|
| V <sub>DS</sub> (V) | R <sub>DS(on)</sub> (Ω)          | I <sub>D</sub> (A) <sup>c</sup> | Q <sub>g</sub> (TYP.) |  |  |  |
|                     | 0.270 at $V_{GS}$ = 4.5 V        | 0.85                            |                       |  |  |  |
| 20                  | 0.390 at V <sub>GS</sub> = 2.5 V | 0.70                            | 1.4 nC                |  |  |  |



## FEATURES

- Trench power MOSFET
- 100 % R<sub>g</sub> tested

#### **APPLICATIONS**

- Smart phones, tablet PC's - DC/DC converters
  - Boost converters
  - Load switch, OVP switch

| ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> =         | = 25 °C, unless other             | wise noted)     |                     |    |  |
|--|-----------------------------------|-----------------|---------------------|----|--|
| PARAMETER  | SYMBOL                            | LIMIT           | UNIT                |    |  |
| Drain-Source Voltage                               |                                   | V <sub>DS</sub> | 20                  | V  |  |
| Gate-Source Voltage                                |                                   | V <sub>GS</sub> | ± 12                |    |  |
|  | T <sub>C</sub> = 25 °C            |                 | 0.85                |    |  |
|  | T <sub>C</sub> = 70 °C            | 1.              | 0.65                |    |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | T <sub>A</sub> = 25 °C            | I <sub>D</sub>  | 0.7 <sup>a, b</sup> |    |  |
|  | T <sub>A</sub> = 70 °C            | 1               | 0.6 <sup>a, b</sup> | А  |  |
| Pulsed Drain Current (t = 300 µs)                  |                                   | I <sub>DM</sub> | 6                   |    |  |
| Cartinuaria Causa Duria Dia da Cumant              | T <sub>C</sub> = 25 °C            |                 | 0.4                 |    |  |
| Continuous Source-Drain Diode Current              | T <sub>A</sub> = 25 °C            | I <sub>S</sub>  | 0.3                 |    |  |
|  | T <sub>C</sub> = 25 °C            |                 | 0.5                 |    |  |
| Maulanum David Dissis ation                        | T <sub>C</sub> = 70 °C            |                 | 0.3                 |    |  |
| Maximum Power Dissipation                          | T <sub>A</sub> = 25 °C            | P <sub>D</sub>  | 0.4 <sup>a, b</sup> |    |  |
|  | T <sub>A</sub> = 70 °C            |                 | 0.3 <sup>a, b</sup> |    |  |
| Operating Junction and Storage Temperature Range   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150     | *0                  |    |  |
| Soldering Recommendations (Peak Temperature)       |                                   |                 | 260                 | °C |  |

| THERMAL RESISTANCE RATINGS       |              |                   |      |      |      |  |
|----------------------------------|--------------|-------------------|------|------|------|--|
| PARAMETER                        |              | SYMBOL            | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient a, d | t ≤ 10 s     | R <sub>thJA</sub> | 250  | 300  | °C/W |  |
| Maximum Junction-to-Foot (Drain) | Steady State | R <sub>thJF</sub> | 225  | 270  | 0/10 |  |

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on  $T_C$  = 25 °C.
- d. Maximum under steady state conditions is 360 °C/W.



FREE

| PARAMETER                                     | SYMBOL                  | TEST CONDITIONS   | MIN. | TYP.  | MAX.  | UNIT  |  |
|---|-------------------------|---|------|-------|-------|-------|--|
| Static  |                         |   |      | •     |       |       |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>         | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA  | 20   | -     | -     | V     |  |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$   | $\Delta V_{DS}/T_J$ In = 250 µA   |      | 32    | -     | mV/°C |  |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$ |   |      | -3    | -     |       |  |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$   | 0.5  | -     | 1.0   | V     |  |
|   | I <sub>GSS</sub>        | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 4.5 V  | -    | -     | 0.1   | 0.1   |  |
| Gate-Source Leakage                           |                         | $V_{DS} = 0 V, V_{GS} = \pm 12 V$   | -    | -     | ± 20  |       |  |
|   |                         | V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V   |      |       | 0.1   | μA    |  |
| Zero Gate Voltage Drain Current               | IDSS                    | V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C                 | -    | -     | 10    |       |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>      | $V_{DS} \ge 5 V, V_{GS} = 10 V$   | 2    | -     | -     | А     |  |
| Drain-Source On-State Resistance <sup>a</sup> |                         | $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 1 \text{ A}$                                 | -    | 0.270 | -     | -     |  |
|   | R <sub>DS(on)</sub>     | $V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}$                               | -    | 0.390 | Ω _ 0 |       |  |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>         | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.4 A  | -    | 5     | -     | S     |  |
| Dynamic <sup>b</sup>                          |                         |   |      | •     |       | •     |  |
| Input Capacitance                             | C <sub>iss</sub>        |   | -    | 105   | -     | pF    |  |
| Output Capacitance                            | C <sub>oss</sub>        | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$              | -    | 23    | -     |       |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>        |   | -    | 11    | -     |       |  |
|   | Qg                      | $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 1.4 \text{ A}$ | -    | 2.7   | 4.1   | nC    |  |
| Total Gate Charge                             |                         |   | -    | 1.4   | 2.1   |       |  |
| Gate-Source Charge                            | Q <sub>gs</sub>         | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1.4 \text{ A}$                  | -    | 0.3   | -     |       |  |
| Gate-Drain Charge                             | Q <sub>gd</sub>         |   | -    | 0.5   | -     |       |  |
| Gate Resistance                               | R <sub>g</sub>          | f = 1 MHz   | 1.4  | 7     | 14    | Ω     |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   | -    | 2     | 4     | 1     |  |
| Rise Time                                     | t <sub>r</sub>          | V <sub>DD</sub> = 15 V, R <sub>L</sub> = 13.6 Ω                                       | -    | 9     | 18    |       |  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong 1.1$ A, $V_{GEN} = 10$ V, $R_g = 1 \Omega$                                 | -    | 8     | 16    |       |  |
| Fall Time                                     | t <sub>f</sub>          |   | -    | 8     | 16    |       |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   | -    | 8     | 16    | ns    |  |
| Rise Time                                     | t <sub>r</sub>          | V <sub>DD</sub> = 15 V, R <sub>L</sub> = 13.6 Ω                                       | -    | 13    | 20    | -     |  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong 1.1$ Å, $V_{GEN} = 4.5$ V, $R_g = 1$ $\Omega$                              | -    | 15    | 23    |       |  |
| Fall Time                                     | t <sub>f</sub>          |   | -    | 6     | 12    |       |  |
| Drain-Source Body Diode Characterist          | ics                     |   |      |       |       |       |  |
| Continuous Source-Drain Diode Current         | I <sub>S</sub>          | T <sub>C</sub> = 25 °C  | -    | -     | 0.4   | •     |  |
| Pulse Diode Forward Current <sup>a</sup>      | I <sub>SM</sub>         |   | -    | -     | 6     | A     |  |
| Body Diode Voltage                            | V <sub>SD</sub>         | I <sub>F</sub> = 1.1 A  | -    | 0.8   | 1.2   | V     |  |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>         |   | -    | 8     | 16    | ns    |  |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>         |   | -    | 3     | 6     | nC    |  |
| Reverse Recovery Fall Time                    | ta                      | l <sub>F</sub> = 1.1 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C                      | -    | 5     | -     |       |  |
| Reverse Recovery Rise Time                    | t <sub>b</sub>          |   | -    | 3     | -     | ns    |  |

#### Notes

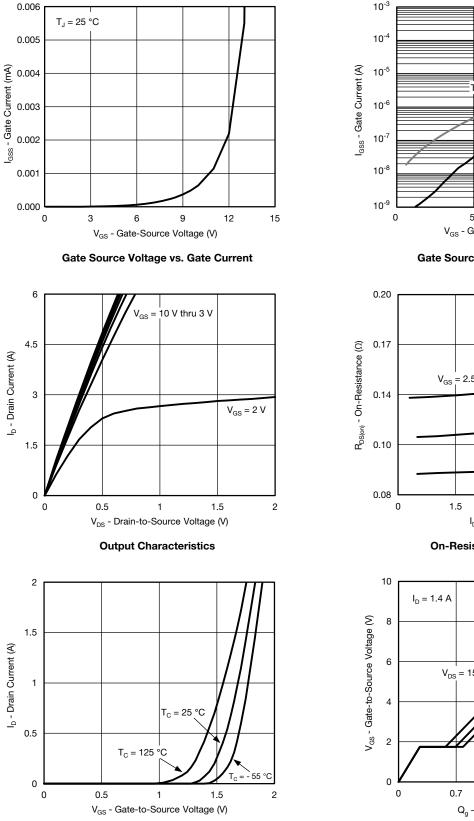
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

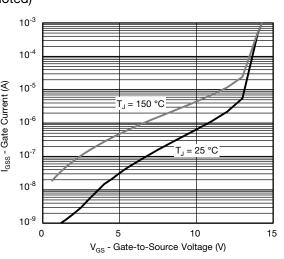
semi



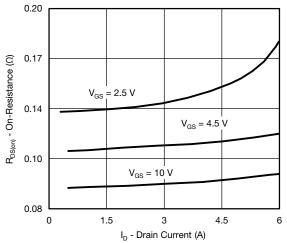


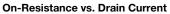


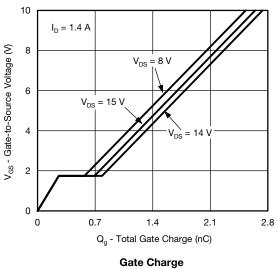




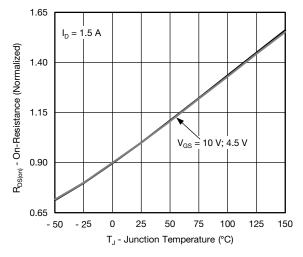
Gate Source Voltage vs. Gate Current



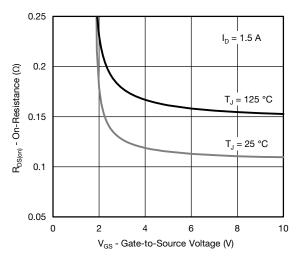




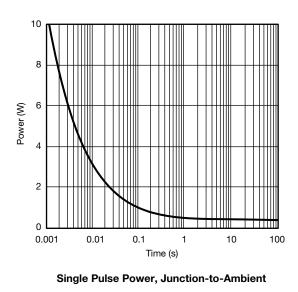


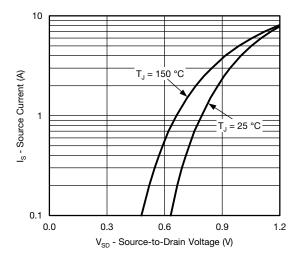


**On-Resistance vs. Junction Temperature** 

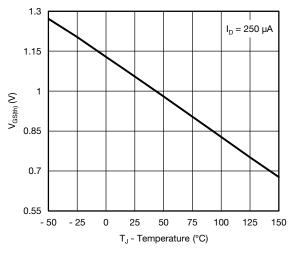


On-Resistance vs. Gate-to-Source Voltage

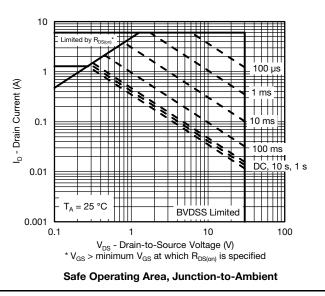




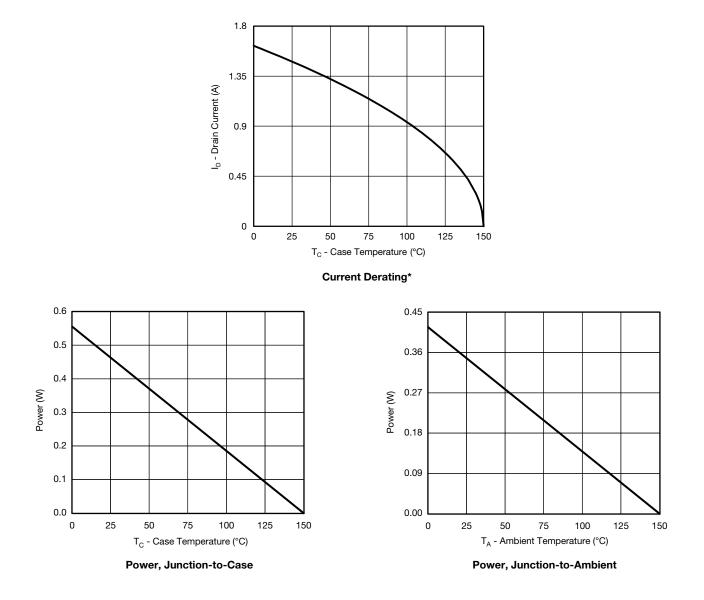
Source-Drain Diode Forward Voltage





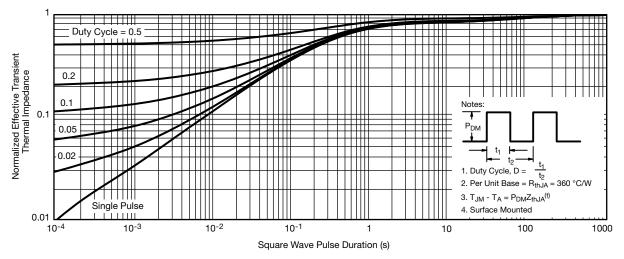




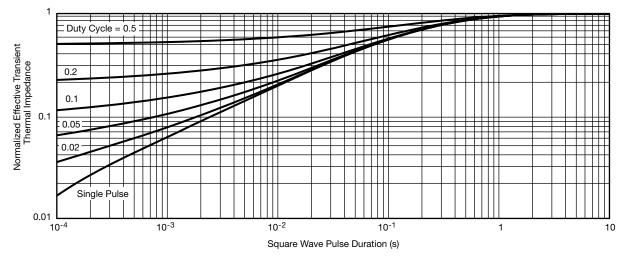


\* The power dissipation  $P_D$  is based on  $T_{J (max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

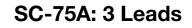


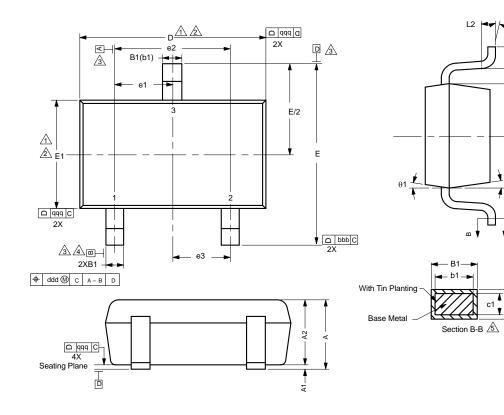
Normalized Thermal Transient Impedance, Junction-to-Foot



θ1

۵





#### Notes

Dimensions in millimeters will govern.

- Dimension D does not include mold flash, protrusions or gate burrs. Mold flash protrusions or gate burrs shall not exceed 0.10 mm per end. Dimension E1 does not include Interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.10 mm per side.
- Dimensions D and E1 are determined at the outmost extremes of the plastic body exclusive of mold flash, tie bar burrs, gate burrs and interelead flash, but including any mismatch between the top and bottom of the plastic body.

 $\underline{3}$  Datums A, B and D to be determined 0.10 mm from the lead tip.

4. Terminal positions are shown for reference only.

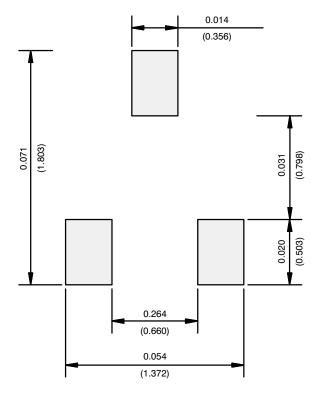
 $\frac{1}{2}$  These dimensions apply to the flat section of the lead between 0.08 mm and 0.15 mm from the lead tip.

| DIMENSIONS | TOLERANCES |  |  |
|------------|------------|--|--|
| aaa        | 0.10       |  |  |
| bbb        | 0.10       |  |  |
| ccc        | 0.10       |  |  |
| ddd        | 0.10       |  |  |

| DIM.           | n in the second s |          |      |      |
|----------------|---|----------|------|------|
| DIM.           | MIN.  | NOM.     | MAX. | NOTE |
| А              | -   | -        | 0.80 |      |
| A <sub>1</sub> | 0.00  | -        | 0.10 |      |
| A <sub>2</sub> | 0.65  | 0.70     | 0.80 |      |
| B <sub>1</sub> | 0.19  | -        | 0.24 | 5    |
| b <sub>1</sub> | 0.17  | -        | 0.21 |      |
| С              | 0.13  | -        | 0.15 | 5    |
| C <sub>1</sub> | 0.10  | -        | 0.12 | 5    |
| D              | 1.48  | 1.575    | 1.68 | 1, 2 |
| E              | 1.50  | 1.60     | 1.70 |      |
| E1             | 0.66  | 0.76     | 0.86 | 1, 2 |
| e <sub>1</sub> |   | 0.50 BSC |      |      |
| e <sub>2</sub> | 1.00 BSC  |          |      |      |
| e <sub>3</sub> |   | 0.50 BSC |      |      |
| L              | 0.15  | 0.205    | 0.30 |      |
| L <sub>1</sub> | 0.40 ref.   |          |      |      |
| L <sub>2</sub> | 0.15 BSC  |          |      |      |
| θ              | 0°  | -        | 8°   |      |
| θ1             | 4°  | -        | 10°  |      |



### **RECOMMENDED MINIMUM PADS FOR SC-75A: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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